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2881

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re the Application of: **Mamoru NAKASUJI et al.**

Group Art Unit: **2881**

Application Number: **09/891,511**

Examiner: **Jack I. BERMAN**

Filed: **June 27, 2001**

Confirmation Number: **8779**

For: **INSPECTION SYSTEM BY CHARGED PARTICLE BEAM AND METHOD OF  
MANUFACTURING DEVICES USING THE SYSTEM**

Attorney Docket Number: **010819**

Customer Number: **38834**

**INFORMATION DISCLOSURE STATEMENT**  
**UNDER 37 C.F.R. §1.97(d)/(e)(1)**

Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

April 27, 2007

Sir:

Applicants direct the attention of the Patent and Trademark Office to the documents listed on the attached PTO/SB/08. A copy of each non- U.S. document is attached.

This Information Disclosure Statement is being submitted after mailing of a final action, a Notice of Allowance, or an action that otherwise closes prosecution in the application, but before or concurrent with payment of the Issue Fee. A check is attached hereto which covers the \$180.00 fee set forth in 37 C.F.R. §1.17(p).

The undersigned hereby certifies that each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. A copy of the foreign communication citing the documents is attached.

04/30/2007 DEMMANU1 00000060 09891511

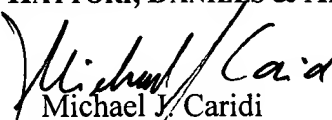
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Information Disclosure Statement under 1.97(d)  
Attorney Docket No. 010819  
Application No. 09/891,511

If there are any fees due in connection with the filing of this paper, please charge Deposit  
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Respectfully submitted,  
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Enclosures: PTO/SB/08  
1 Foreign Communication  
13 Documents  
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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)				<i>Complete if Known</i>		
				Application Number		09/891,511
				Confirmation Number		8779
				Filing Date		June 27, 2001
				First Named Inventor		Mamoru NAKASUJI et al.
				Art Unit		2881
Examiner Name		Jack I. BERMAN				
Attorney Docket Number		010819				
Sheet	1	of	1			

### U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code <sup>2</sup> (if known)		
	1.	US 4,680,467		07-14-1987	Bryson, III et al.
	2.	US 5,986,263		11-16-1999	Hiroi et al.
	3.	US 5,376,883		12-27-1994	Kaito
	4.	US 5,432,345		07-11-1995	Kelly

### FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Translation <sup>6</sup>
		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)			
	5.	JP	2000047371	A	02-18-2000	SEIKO INSTRUMENTS INC	Abstract
	6.	WO	98/32153		07-23-1998	KLA-TENCOR CORPORATION	
	7.	JP	57119442	A	07-24-1982	MITSUBISHI ELECTRIC CORP	Abstract
	8.	WO	00/72355	A1	11-30-2000	KLA-TENCOR CORPORATION	
	9.	JP	04331390	A	11-19-1992	NEC CORP	Abstract
	10.	EP	1 219 956	A2	07-03-2002	PHYSICAL ELECTRONICS, INC.	
	11.	JP	57147857	A	09-11-1982	HOJO KIICHI	Abstract
	12.	EP	0 848 247	A1	06-17-1998	PHYSICAL ELECTRONICS, INC.	
	13.	JP	10012684	A	01-16-1998	HITACHI LTD	Abstract
	14.	JP	08222176	A	08-30-1996	HITACHI LTD	Abstract
	15.	EP	0 200 333	A2	12-10-1986	MICRION LIMITED PARTNERSHIP	
	16.	JP	62093934	A	04-30-1987	HITACHI LTD	Abstract
	17.	JP	06338280	A	12-06-1994	NIKON CORP	Abstract

### NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation <sup>6</sup>
	18.	European Search Report dated March 19, 2007, issued in corresponding European Patent Application Number 01 94 5627.	

Examiner Signature	Date Considered
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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